

<b>Notice of References Cited</b>	Application/Control No. 10/717,533	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Jermele M. Hollington	Art Unit 2829	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,803,563 A	02-1989	Dailey et al.	324/262
	B	US-4,970,890 A	11-1990	Jaafar et al.	73/12.09
	C	US-4,996,486 A	02-1991	Posedel, Zlatimir	324/545
	D	US-5,252,927 A	10-1993	Bruhlmeier et al.	324/546
	E	US-5,295,388 A	03-1994	Fischer et al.	73/12.09
	F	US-5,341,095 A	08-1994	Shelton et al.	324/772
	G	US-5,557,216 A	09-1996	Dailey et al.	324/772
	H	US-5,990,688 A	11-1999	Bourgeois et al.	324/545
	I	US-6,469,504 B1	10-2002	Kliman et al.	324/228
	J	US-6,489,781 B1	12-2002	Kliman et al.	324/545
	K	US-2003/0117144 A1	06-2003	Sutton, John	324/546
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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